- Contents -

• 보시	1p
•목차	3р
1. Revision History	4p
2. Features & Applications	5р
3. Electrical Specifications	6р
4. Measurements Method & Conditions	11p
5. PCB Layout & Solder Pad size	12p
6. Antenna Dimensions	15p
7. Marking View	15p
8. Reflow Profile	16p
9. Environmental Tests	17p
10. Packaging	18p
11. Usage and Cautions	18p
12. RoHS Data	19p

1. Revision History

product	NKC-POS_A	١	Мос	del SRP-350IIOBE			
Rev. No.	Rev. Issue	Pa	ge	Designed		Date	
1.0	Appro. Issue	_	_	KC	C. NAM	2013.01.02	
					1,		
			X				
	() ,						

2. Features & Applications

2.1 Features

This ceramic chip antenna is applied to 2.4 GHz ISM band applications, i.e. Bluetooth. Zigbee, Wireless LAN, etc...

형태		Bulk Ceramic
	유전체	Al2O3(Alumina)
재질	전극	은(Ag)
크기 (mm)	L = 10 + 10 - 10 = 10 = 10 = 10 = 10 = 10 = 10 =	
Weight	97~100 mg	

3. Electrical Specifications

3-1.

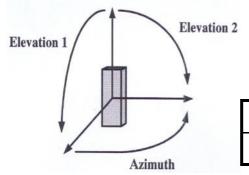
- * All item are measured in room temperature (24~25 °C).
- * All item are measured at customer set condition.

No.	Items	Typical Data
1	Frequency (MHz)	2400 ~2500
2	VSWR	1.5 : 1
3	Total Gain (Peak) [dBi]	0
4	Impedance	50 ohm
5	Polarization	Linear





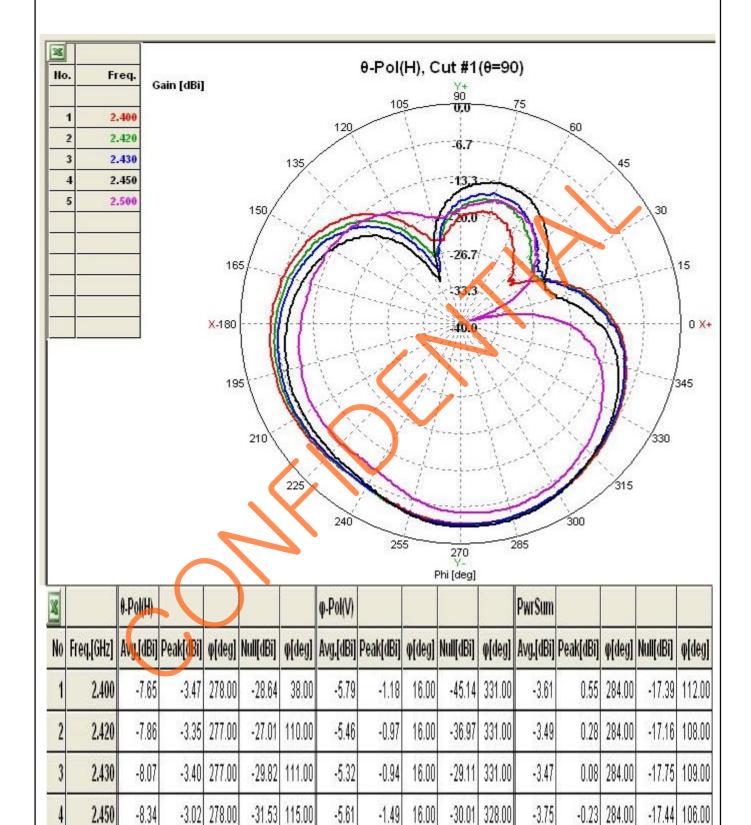
3-3. Radiation Patterns



Theta	Vertical Field of measured plane
Phi	Horizontal Field of measured plane

	Azimuth	Phi	Peak	-3.02
이득[dBi]	Azimuth	PIII	Avg	-8.34
(Co-Pola)	Elevation	Thata	Peak	-0.94
	Elevation	Theta	Avg	-5.32

(Azimuth)



-10.65

-5.25

284.00

2.500

-38.25

17.00

-7.53

-3.98

13.00

-23.62

329.00

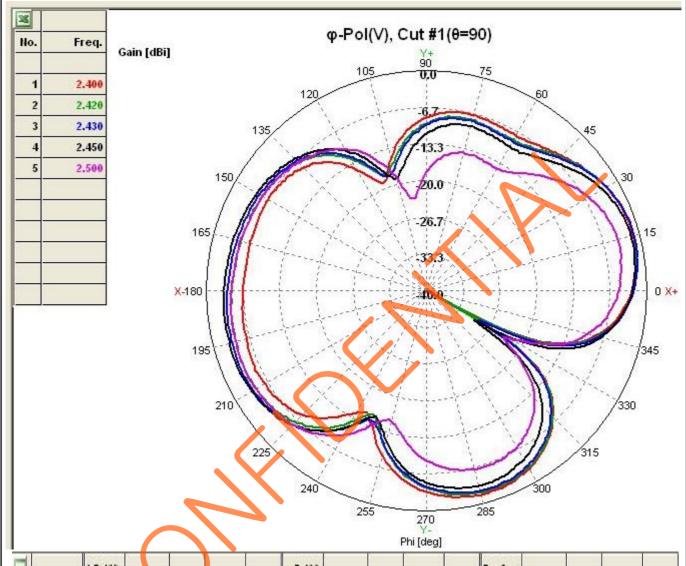
-5.80

-18.68 100.00

284.00

-2.83

(Elevation)

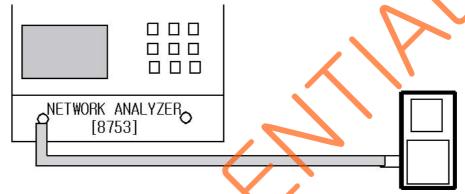


×		0-Pol(H)					φ-Pol(V)					PwrSum				
No	Freq.[GHz]	Avy.[dBi]	Peak[dBi]	φ[deg]	Null(dBi)	φ[deg]	Avg.[dBi]	Peak(dBi)	φ[deg]	Null[dBi]	φ[deg]	Avg.[dBi]	Peak[dBi]	φ[deg]	Null(dBi)	φ[deg]
1	2.400	-7.65	-3.47	278.00	-28.64	38.00	-5.79	-1.18	16.00	-45.14	331.00	-3.61	0.55	284.00	-17.39	112.00
2	2.420	-7.86	-3.35	277.00	-27.01	110.00	-5.46	-0.97	16.00	-36.97	331.00	-3,49	0.28	284.00	-17,16	108.00
3	2.430	-8.07	-3.40	277.00	-29.82	111.00	-5.32	-0.94	16.00	-29.11	331.00	-3.47	0.08	284.00	-17.75	109.00
4	2.450	-8.34	-3.02	278.00	-31.53	115.00	-5.61	-1.49	16.00	-30.01	328.00	-3.75	-0.23	284.00	-17.44	106.00
5	2.500	-10.65	-5.25	284.00	-38.25	17.00	-7,53	-3.98	13.00	-23,62	329.00	-5.80	-2.83	284.00	-18.68	100.00

4. Measurements Method & Conditions

The measurement of antenna performance is measurement of gain, radiation pattern using ORBIT/FR apparatus in Anechoic chamber and measurement of VSWR using Network analyzer.

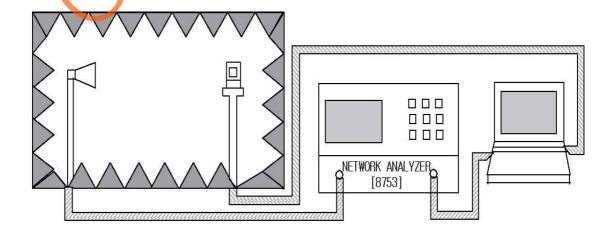
4-1. The measurement of Frequency and VSWR



[Measurement Method]

- 1. As seen the above, network analyzer is set up for S11 measurement.
- 2. The measurement frequency range is to set up from 2 GHz to 3 GHz.
- 3. Perform S11 one port full calibration.
- 4. Measure the VSWR of three points of Bluetooth frequency range such as 2.4 GHz, 2.45 GHz, and 2.5 GHz.

4-2. The measurement of Gain & Radiation Patterns



[Measurement Method]

- 1. As seen the above, network analyzer is to set up in Anechoic chamber.
- 2. As seen beneath, for the measurement planes as Azimuth, Elevation 1, and Elevation 2, measure Gain data of vertical polarization and horizontal polarization for each plane.

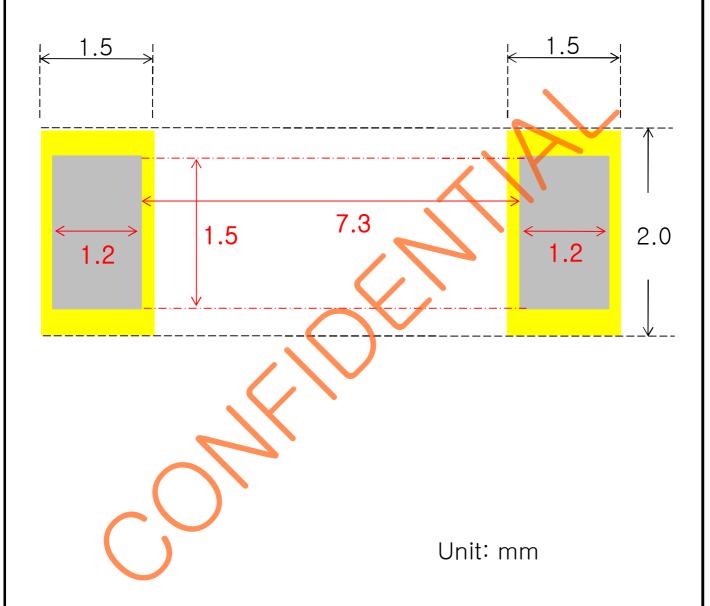


Unit: mm

tolerances: +/- 0.05

12/21 page

5-2. Pad size & SOLDERING CREAM AREA



Soldering Cream의 면적은 SMD 업체 현황(메탈 스크린 두께, 온도)에 따라 변경 될 수 있으므로 협의를 요함





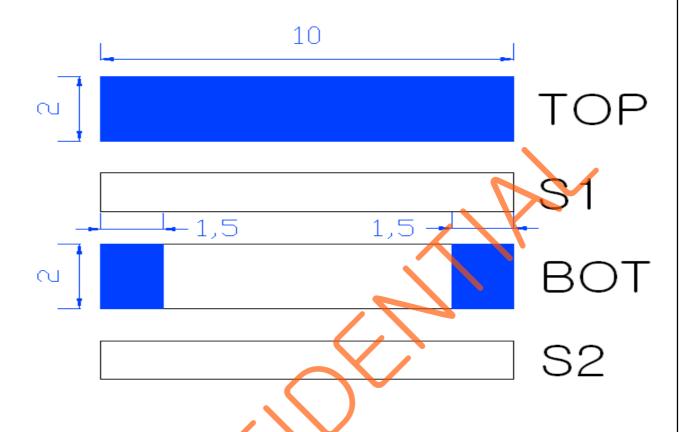
Ver 1.0 (2013.01.02)

13/21 page









7. Marking View



Only TOP part

7-1. 마킹 종류

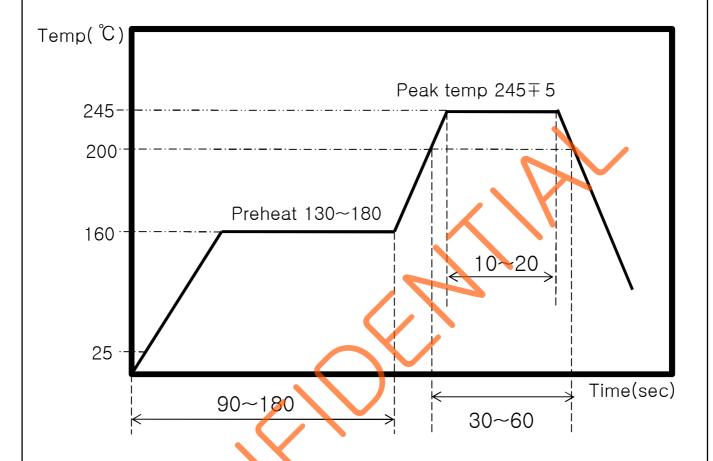
* RF용 검정 잉크 사용

Ver 1.0 (2013.01.02)

15/21 page

8. Reflow Profile

8-1. Standard reflow condition(Pb-free)



SMD 업체 현황에 따라 peak temp 및 시간은 변경 될 수 있으므로 협의를 요함

8-2. 수동 납땜 (인두기)을 할 경우(Pb-free)

인두 온도: 340 'C / 시간: 각 단 max 3 sec

9. Environmental Tests

No.	ITEM	TEST COND	TEST REQU
1	High Temperature Resistance	 Temp: +125±5℃ Time: 1000±24hrs Measure Fc after left for 24hrs min. at room temp 	Within electric spec(VSWR) No visual damage
2	Low Temperature Resistance	 Temp: -40±5°C Time: 1000±24hrs Measure Fc after left for 48hrs min. at room temp 	1. Within electric spec(VSWR) 2. No visual damage
3	Thermal Shock	 1. 1cycle/step1:-40±3℃,30min step2:+125±3℃,30min 2. Number of cycle:30 3. Measure after left for 48hrs min. at room temp 	 Within electric spec(VSWR) No visual damage
4	Humidity	 Humidity:85%RH Temp:+85±3°C Time:1000±24hrs Measure Fc after left for 48hrs min. at room temp 	 Within electric spec(VSWR) No visual damage
5	Adhesive strength of termination	1. Applied force on SMD chip till detached point from PCB.	1. No mechanical damage by forces applied on the right 2. Strength(F)>5kgf